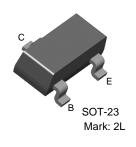


SEMICONDUCTOR

MMBT5401

PNP General Purpose Amplifier

• This device is designed as a general purpose amplifier and switch for applications requiring high voltage.



MMBT5401

PNP Epitaxial Silicon Transistor

Symbol	Parameter		Value	Units
V _{CEO}	Collector-Emitter Voltage		-150	V
V _{CBO}	Collector-Base Voltage		-160	V
V _{EBO}	Emitter-Base Voltage		-5.0	V
I _C	Collector Current - C	Continuous	-600	mA
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 ~ 150	°C

Absolute Maximum Ratings* T_a=25°C unless otherwise noted

* These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

Notes:

These ratings are based on a maximum junction temperature of 150 degrees C.
These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

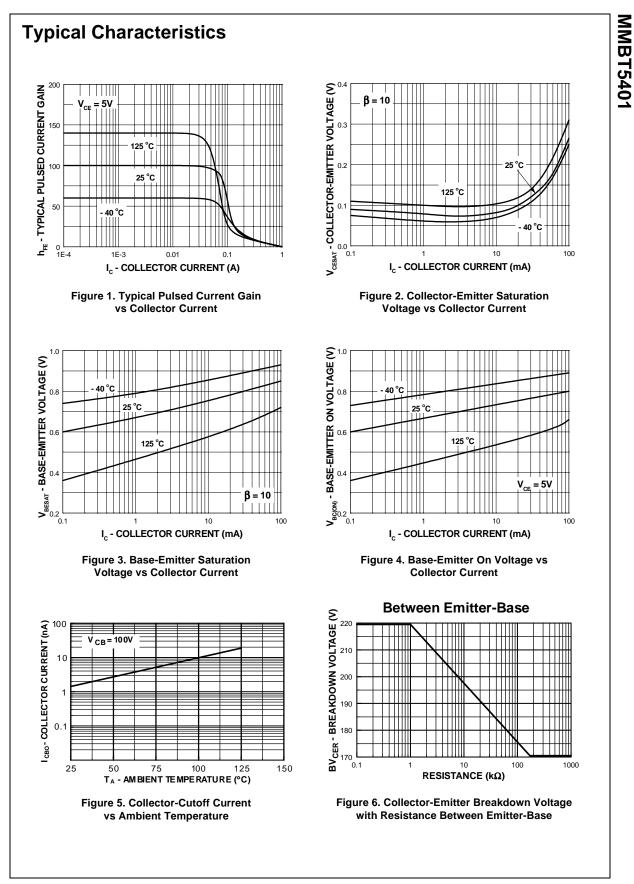
Electrical Characteristics T_a=25°C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Max.	Units
Off Charac	teristics	· · ·			
BV _{CEO}	Collector-Emitter Breakdown Voltage *	I _C = -1.0mA, I _B = 0 -150			V
BV _{CBO}	Collector-Base Breakdown Voltage	$I_{C} = -100\mu A, I_{E} = 0$	-160		V
BV _{EBO}	Emitter-Base Breakdown Voltage	$I_{E} = -10\mu A, I_{C} = 0$	-5.0		V
I _{CBO}	Collector Cutoff Current	$V_{CB} = -120V, I_E = 0$ $V_{CB} = -120V, I_E = 0, T_a = 100^{\circ}C$		-50 -50	nA μA
I _{EBO}	Emitter Cutoff Current	V _{EB} = -3.0V, I _C =0		-50	nA
On Charac	teristics *				
h _{FE}	DC Current Gain	$\begin{split} I_{C} &= -1.0 \text{mA}, \ V_{CE} &= -5.0 \text{V} \\ I_{C} &= -10 \text{mA}, \ V_{CE} &= -5.0 \text{V} \\ I_{C} &= -50 \text{mA}, \ V_{CE} &= -5.0 \text{V} \end{split}$	50 60 50	240	
V _{CE} (sat)	Collector-Emitter Saturation Voltage	$I_{C} = -10mA, I_{B} = -1.0mA$ $I_{C} = -50mA, I_{B} = -5.0mA$		-0.2 -0.5	V V
V _{BE} (sat)	Base-Emitter Saturation Voltage	I _C = -10mA, I _B = -1.0mA I _C = -50mA, I _B = -5.0mA		-1.0 -1.0	V V
Small Sigr	al Characterics				
f _T	Current Gain Bandwidth Product	I _C = -10mA, V _{CE} = -10V, 100 3 f = 100MHz		300	MHz
C _{ob}	Output Capacitance	V _{CB} = -10V, I _E = 0, f = 1MHz		6.0	pF
N _F	Noise Figure	$I_{C} = -250\mu A$, $V_{CE} = -5.0V$, $R_{S} = 1.0K\Omega$ f = 10Hz to 15.7KHz		8.0	dB

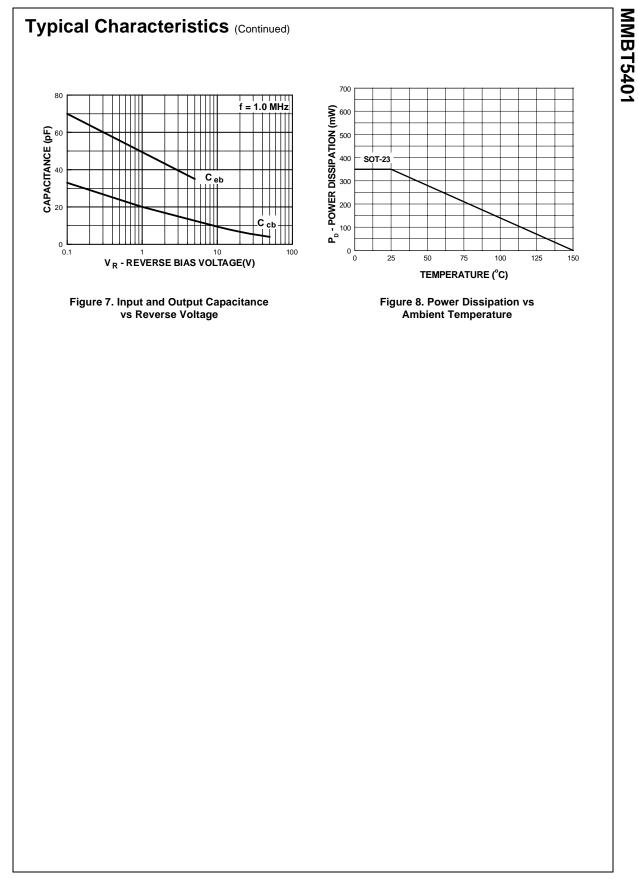
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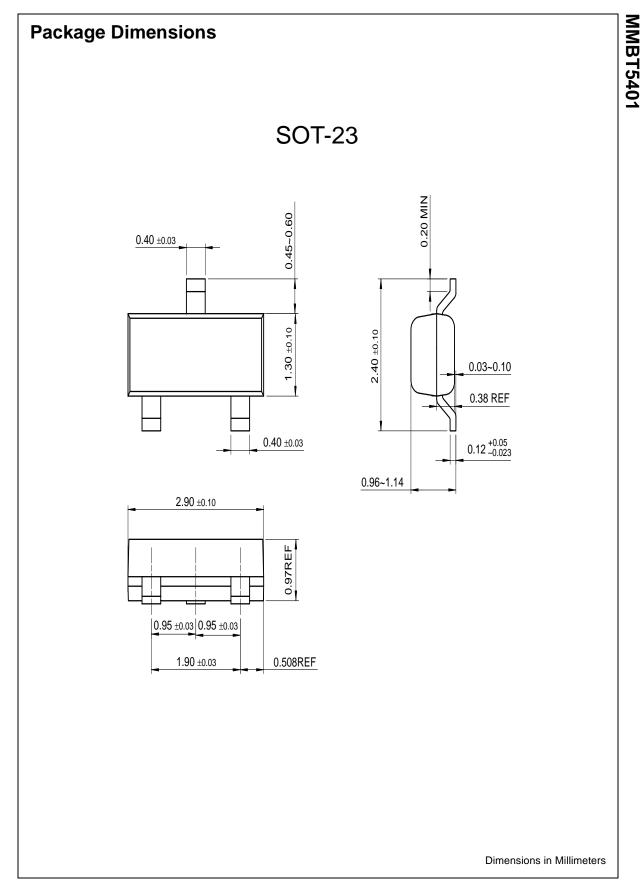
Symbol	Parameter	Max.	Units
°D	Total Device Dissipation	350	mW
-	Derate above 25°C	2.8	mW/°C
R _{0JA}	Thermal Resistance, Junction to Ambient	357	°C/W

Rev. B1, August 2004



Rev. B1, August 2004





Rev. B1, August 2004

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